



## **SELF-ACTIVATED FRONT SURFACE BIAS FOR A SOLAR CELL**

### **CROSS-REFERENCE TO RELATED APPLICATIONS**

[001] This application claims the benefit of provisional patent application 61/488,628 filed on May 20, 2011, which is hereby incorporated by reference in its entirety.

### **FIELD**

[002] This disclosure relates in general to the field of solar photovoltaics, and more particularly to electrical connections and conversion efficiency enhancement for back contact solar cells.

### **BACKGROUND**

[003] Consider a solar cell (SC) wherein most of the front surface (FS) – the solar cell side receiving sunlight, also called the sunny surface or sunnyside - is NOT directly connected to an emitter or base. In one known SC design, the SC has contacts and wires for emitters and bases near or on the back surface (BS) – also called the shady surface, non-sunnyside, or backside. In another known solar cell design, the solar cell has the base contact on the back surface and emitter contacts that penetrate (“wraps through”) the solar cells.

[004] Solar cells often suffer from wasted energy near the front surface. For short wavelength light on a crystalline silicon solar cell, light absorption and generation of electrons and holes (electron-hole pairs) occurs very close to the front surface. In this region, if there are any electronic traps or recombination centers, the energy in electrons or holes may be absorbed and degraded into heat and thus wasted. Depending on details of solar cell fabrication and passivation, it may be difficult to sufficiently minimize such traps and recombination centers.

[005] Solar cells also often suffer from uneven illumination. Consider a number of solar cells connected in series and one solar cell is shaded but the other connected solar cells are brightly illuminated. In this case, the illuminated solar cells will generate much more power than the shaded solar cell. Therefore, power is generated by the illuminated solar cells and is dissipated in the shaded solar cell. This may cause the shaded SC to become very hot and suffer

permanent damage. One solution to this problem is to provide a bypass diode in parallel with a solar cell or in parallel with a series string of solar cells.

**[006]** Known solutions for solar cell front surface degradation include a solar cell with a bias voltage or charge on a transparent conductive layer (or “gate”) on the sunny surface of the solar cell to minimize recombination. Another known solution includes a gate on the sunny surface of the solar cell to minimize recombination.

**[007]** Known solutions to the problems above, front surface degradation and unequal illumination, are very separate. In other words, the solutions for one problem do NOT provide solutions to the other.

**SUMMARY**

**[008]** Therefore a need has arisen for solar cell assembly which provides a solution to front surface degradation. In accordance with the disclosed subject matter, solar cell assembly is provided which substantially eliminates or reduces disadvantages associated with previously developed solar cell assemblies.

**[009]** According to one aspect of the disclosed subject matter, a self-activated front surface bias for photovoltaic solar cell assembly is provided. The solar cell assembly comprises a front surface bias activated by energy generated by the solar cell assembly. The front surface bias improves generation efficiency for said solar cell assembly.

**[010]** These and other aspects of the disclosed subject matter, as well as additional novel features, will be apparent from the description provided herein. The intent of this summary is not to be a comprehensive description of the claimed subject matter, but rather to provide a short overview of some of the subject matter's functionality. Other systems, methods, features and advantages here provided will become apparent to one with skill in the art upon examination of the following **FIGURES** and detailed description. It is intended that all such additional systems, methods, features and advantages that are included within this description, be within the scope of any claims filed later.

**BRIEF DESCRIPTION OF THE DRAWINGS**

[011] The features, natures, and advantages of the disclosed subject matter may become more apparent from the detailed description set forth below when taken in conjunction with the drawings in which like reference characters identify correspondingly throughout and wherein:

[012] **FIGURE 1A** is a diagram depicting overall a solar cell assembly in accordance with the disclosed subject matter;

[013] **FIGURE 1B** is a diagram highlighting another embodiment of the solar cell front surface layers and the bias wire connection;

[014] **FIGURE 1C** is a diagram depicting another embodiment solar cell assembly embodiment in accordance with the disclosed subject matter;

[015] **FIGURES 2A-2C** are diagrams showing several embodiments of an integrated circuit in accordance with the disclosed subject matter;

[016] **FIGURE 3A** is diagram depicting a panel level embodiment of disclosed subject matter; and

[017] **FIGURE 3B** is a diagram highlighting an integrated circuit embodiment and solar assembly design of **FIGURE 3A**.

## **DETAILED DESCRIPTION OF THE SPECIFIC EMBODIMENTS**

[018] The following description is not to be taken in a limiting sense, but is made for the purpose of describing the general principles of the present disclosure. The scope of the present disclosure should be determined with reference to the claims. And although described with reference to a back contact back junction solar cell a person skilled in the art could apply the principles discussed herein to various solar cell designs.

[019] Preferred embodiments of the present disclosure are illustrated in the drawings, like numbers being used to refer to like and corresponding parts of the various drawings.

[020] In a solar cell, if an electron and hole (produced by an incident solar photon) recombine at the solar cell front surface then their energy will be wasted. The disclosed subject matter provides a solution to prevent this waste by utilizing a front-surface bias to improve photo-voltaic conversion efficiency by reducing the effective front surface recombination velocity. On the front surface, a bias voltage is applied which produces front surface charges with the same polarity as minority carriers. This causes an electrical field that pushes minority carriers away from the front surface which reduces the concentration of minority carriers and reduces recombination near the front surface - thus improving photovoltaic efficiency. For example, in a solar cell with n-type doping (or n-type base) holes are the minority carriers and a positive bias produces front surface positive charges that repel minority carriers, hence reducing the effective front surface recombination velocity.

[021] **Fig. 1A** is a diagram depicting overall solar cell assembly **1000**, including a semiconductor solar cell **1100**. In the present disclosure, when the solar cell assembly operates, the front surface is illuminated by sunlight and the back surface is shaded. On the solar cell back surface are emitters **1310** and bases **1320** and corresponding contacts and wires **1410** and **1420** (wires **1410** and **1420** shown as discrete lines but are actually deposited on the solar cell back surface). Near the solar cell front surface are five layers: trapped charge layer **1210** (shown as dots in dispersed in the cell); texture layer **1220**; passivation layer **1230**; transparent conductive layer **1250**; outer window layer **1260**.

[022] Transparent conductive layer **1250** may be a fully transparent or semi-transparent conductive layer - embodiments include a thin layer of Indium Tin Oxide, or Zinc oxide with Al doping, or a mesh of carbon nano-tubes, or a mesh of silver nanowires. Also, it may be feasible to use a graphene layer that is ultra-thin, transparent, and electro-conductive. Further, the inner window layer **1250** and/or outer window layer **1260** may be a transparent dielectric.

[023] **Fig. 1A** shows integrated circuit chip **1500** (IC) that provides a bias circuit embodiments which are further depicted in **Figs. 2A-2B**. IC **1500** has several connections: emitter wire **1410**; emitter output wire **1411**; base wire **1420**; base output wire **1421**; and bias wire **1430**. In this embodiment, bias wire **1430** connects to transparent conductive layer **1250** on the front surface of the solar cell. This is surrounded by electrical insulation **1431**. This embodiment provides ohmic coupling from transparent conductive layer **1250** to solar cell **1100**. The transparent conductive layer **1250** may provide an ohmic connection between the bias circuit and the solar cell. In addition, the IC circuit may also include a bypass circuit, shown as **1520** in **Figs. 2A-2C**. For example, a bypass diode, such as bypass diode **1521**, may be connected between emitter and base wires. This protects the solar cell against possible resistive overheating when series connected solar cells are unequally illuminated.

[024] **Fig. 1A** and all of the following figures (**Fig. 1A-3B**) combine several graphical styles. The structures and thin layers of solar cell **1100** are not drawn to scale but are exaggerated for descriptive purposes. Further, emitter wires **1410** and base wires **1420** are actually deposited on the back surface **1300** of the solar cell **1100** although these are drawn as discrete lines. Also, connections between wires are marked by dots - thus wire lines that cross without dots are not connected. And although not shown, gate control signals are provided by other circuits.

[025] **Fig. 1A** shows an ohmic coupling between transparent conductive layer **1250** and solar cell **1100**. Through bias wire **1430**, this dissipates power equal to the current times bias voltage. It is desirable for this dissipated power to be small compared to the cell output power. By contrast, the embodiment shown in **Fig. 1B** has a capacitive coupling which on average has tiny current density and tiny dissipation.

[026] Transparent conductive layer **1250** should be sufficiently transparent not to significantly attenuate the light that reaches the solar cell. For example, optical attenuation less than 2% is desirable. Further, there should be sufficient in-plane electrical conductivity so this layer is approximately at a uniform voltage. For example, the voltage difference across the plane over the cell area should preferably be less than 0.05 volts. Further, for an embodiment with capacitive coupling (such as **Fig. 1B**), the in-plane current and current density are very small thus a relatively small in-plane conductivity is sufficient.

[027] **Fig. 1B** is a diagram highlighting another embodiment of the solar cell front surface layers and the bias wire connection. In this embodiment, the layers are slightly different: trapped charge layer **1210**; texture layer **1220**; passivation layer **1230**; dielectric inner window layer **1240**; transparent conductive layer **1250**; outer window layer **1260**. In contrast with **Fig. 1A**, this shows capacitive coupling from transparent conductive layer **1250** through dielectric inner window layer **1240** to the solar cell **1100**.

[028] **Fig. 1C** is a diagram depicting another embodiment overall solar cell solar cell assembly **1000**, including a semiconductor solar cell **1100**. Here, emitter wire **1410** is directly connected to bias wire **1430** and hence to transparent conductive layer **1250**. Bypass protection circuit **1520** may be a conventional bypass diode **1521** connected between emitter wires **1410** and base wires **1420**. Solar cell **1100** of **Fig. 1C** has a front surface with layers shown in **Fig. 1B**, including inner window layer **1240**.

[029] This solar cell assembly of **Fig. 1C** may have a lower cost because of lower fabrication cost and utilizing conventional assembly processes. In this IC design, bias wire **1430** may directly connect from the solar cell electrode (either emitter **1310** or base **1320**) with the same polarity as minority carriers in the solar cell. This electrode wire, which may be either emitter wire **1410** or base wire **1420** depending on the polarity of the minority carriers in the solar cell, and bias wire directly feed the front surface transparent conductive layer **1250**. In **Fig. 1C**, this is shown as the connection of bias wire **1430** to emitter wire **1410**. The solar cell electrodes are connected to emitter wires **1410** and base wires **1420**, which may be bus bars (for example flexible metal ribbons or

printed circuits). Bias wire **1430** may be a distinct wire or an extension of the positive bus bar and the connections may use solder or an electro-conductive adhesive.

[030] In one example, the solar cell semiconductor is n-type silicon and the base and emitter contacts (electrodes) and corresponding semiconductor junctions are all close to the back surface. This structure is sometimes described as “back contact and back junction” or BCBJ solar cell (also called interdigitated back contact or IBC). The emitters are the positive electrodes that connect to a positive bus bar which connects to a distinct bias wire that connects to the transparent conductive layer (the design diagramed in **Fig. 1C**). In a slightly different embodiment, the bias wire is a “through silicon via” or TSV. Similar vias are known in the design of semiconductor chips.

[031] **Figs. 2A - 2C** are diagrams showing several embodiments of IC **1500**. Each embodiment shown provides a bias circuit **1510** and a bypass circuit **1520**.

[032] In the integrated circuit embodiment of **Fig. 2A**, IC **1500**, bias circuit **1510** is a voltage divider formed by two resistors, **1511-1** and **1511-2**, connected between emitter wire **1410** and base wire **1420**. Bias wire **1430** connects to the transparent conductor layer **1250** of the solar cell but is insulated from other parts of the cell. The bypass circuit **1520** is a diode **1521**. In the IC design of **Fig. 2A**, the bypass circuit **1520** is a semiconductor diode **1521** designed for a small forward voltage drop at a large forward current.

[033] In the integrated circuit embodiment of **Fig. 2B**, IC **1500**, bias circuit **1510** is a voltage divider formed by two transistors, **1512-1** and **1512-2**. The bypass circuit **1520** is a transistor **1522**. Each transistor **1513-1**, **1513-2**, **1523** has a gate that connects to an individual control signal **1514-1**, **1514-2**, **1524** (not shown) that is also provided. In this embodiment, the bypass circuit **1520** includes a transistor(s) **1522** that is designed for high current with small voltage drop when its gate **1524** is turned on. IC chip **1500** is connected between the emitter **1410** and base wires **1420** and bias wire **1430** provides voltage tap that is connected to the front surface transparent conductive layer **1250**. The control inputs into the transistor gates, **1514-1** and **1514-2**, adjust the voltage division ratio and thus adjusts the bias voltage that is connected to the front surface transparent

conductive layer **1250**. These control inputs are driven by an analog input or by a digital input through a digital to analog converter.

[034] The bias means and bypass means preferably are unified: share one tiny piece of semiconductor, its electronic “package”, and its assembly into the solar cell assembly. If necessary, this can include an auxiliary component(s) for voltage step up. In high volume production, the cost and size are preferably only slightly more than those for the bypass protection alone.

[035] In the integrated circuit embodiment of **Figs. 2A** and **2B** there is partial unification and significant synergism between the bias circuit **1510** and the bypass circuit **1520**. Both circuits may be connected to the solar cell emitter wire **1410** and solar cell base wire **1420** and one integrated circuit may provide both bias and bypass circuits. Allowing both bias and bypass circuits to take advantage of electronic devices (wiring, resistor, diode, transistor, electronic “packaging”) provided by the IC – thus lower manufacturing costs. Depending on costs, an IC with both circuits may be fabricated directly into the semiconductor of the solar cell (as shown in **Fig. 2C**). For example, both circuits may be fabricated in a tiny area near a corner of the back side **1300** of a crystalline silicon solar cell **1100**.

[036] In another embodiment, one bias circuit provides bias to several solar cells (for example a solar panel as shown in **Fig. 3A-3B**). For example, several solar cells may be approximately equal in optimum bias and operating conditions. The former depends mainly on cell fabrication and the latter depends on the layout of the solar farm. If the solar cells are connected in series, each solar cell bias should be offset by a corresponding voltage - thus one bypass circuit may provide bypass protection for a string of solar cells.

[037] In the integrated circuit embodiment of **Fig. 2C**, the IC of **Fig. 2B** is fabricated on a surface of the solar cell having the same front surface layer structure as that shown in **Fig. 1A**. For example, the IC may be positioned on a tiny area near a corner of the back surface of the solar cell. Bias wire **1430** connects from the bias circuit **1510** to front surface transparent conductive layer **1250**. In one embodiment bias wire **1430** is discrete and in another embodiment bias wire **1430** and the bias wire insulation are

integrated with the solar cell. This is analogous to a “through silicon via” (TSV) in some IC chips.

**[038]** This design may be particularly suitable for fabrication of a crystalline silicon solar cell where the bias circuit **1510** may be fabricated as part of the solar cell. For example a transistor, **1512-1**, **1512-2**, and **1522**, (and/or resistors) and wiring, including bias wire **1430**, are fabricated on the back of the solar cell.

**[039]** The disclosed bias circuit **1500** is engineered to provide a bias that optimizes the output power of the solar cell. For example, this may depend on the solar cell temperature, output current, and output voltage. In one embodiment, the bias circuit has means to measure operating parameters such as: solar cell temperature; solar cell output current; solar cell output voltage; bias current to/from the front surface coating. These measurements may be inputs to an algorithm to provide the optimum bias voltage and the algorithm may be implemented by analog means and/or digital means.

**[040]** In one embodiment, the bias circuit provides a negative feedback loop that adjusts the bias to optimize the output power. In another embodiment, the bias circuit effectively implements an open-loop algorithm to provide optimum bias. In yet another embodiment, the bias circuit includes an open-loop algorithm to provide an approximate optimum bias plus a feedback loop for fine-tuning to the exact optimum bias.

**[041]** The disclosed solar cell designs may be self-powering by using energy generated by the solar cell to activate bias. When illuminated by sunlight, the solar cell directly generates electrical power, including voltage and current, which may be used to activate the disclosed bias circuit. The energy generated by the solar cell activates electrical bias on the transparent conductive layer on the front surface of the solar cell. In the embodiment shown in **Fig. 1A**, there is ohmic contact between the transparent conductive layer and the solar cell - thus some of the generated energy activates a bias voltage and a bias current. In the embodiment shown in **Fig. 1B**, there is a dielectric inner window layer between the transparent conductive layer and the solar cell. Between these two layers is capacitive coupling but not sustained current coupling - thus some of the generated energy activate a bias voltage comprises an applied voltage with nil sustained current.

[042] Thus, the bias circuit and its power activation source are both within the solar cell assembly and there is not a need for an external connection or external power source to activate the bias circuit – in other words, the bias is self-activated. The electrical energy(ies) generated by the solar cell activates a bias voltage. This is applied to a transparent conductive layer on the front surface of at least one solar cell. This repels minority carriers, and thus reduces surface recombination, and thus improves photovoltaic efficiency. The solar cell assemblies disclosed may have only two external electrical connections, outputs for emitter and base (shown as **1411** and **1421** respectively). The disclosed solar cell assemblies are substantially compatible with structures and assembly processes for a panel of conventional solar cells.

[043] By contrast, a separately packaged bypass diode and separate packaged bias circuit may be less compatible with a conventional packaged bypass diode by itself. Further, a solar cell assembly using three external electrical connections may be less compatible with a conventional panel and its assembly processes.

[044] In the embodiment shown in **Fig. 1B**, the bias voltage is applied to a series circuit including dielectric inner window layer **1240** and the semiconductor material of the solar cell. The dielectric inner window layer **1240** will drop a substantial part of the bias voltage and this reduced remaining voltage will drop across the semiconductor material and contribute to the E-field and decrease the front surface recombination (FSR). To make FSR sufficiently small will require a sufficiently large electrical field in the semiconductor solar cell. A larger bias voltage may be necessary to compensate for this reduction and it may be desirable for the bias voltage to exceed the voltage directly generated by the solar cell. For example, solar cell voltage is typically in the range of 0.5V for a silicon solar cell so a corresponding bias voltage equal to or greater than 0.5V.

[045] In a corresponding embodiment, the bias circuit may step up voltage, from the voltage directly generated by the solar cell, to a larger bias voltage. Means to step up voltage include a DC to DC switched capacitor voltage multiplier. This is well suited to drive the capacitive load formed by the transparent conductive layer, inner window layer, and semiconductor solar cell. This step up circuit may be provided by the IC plus a small auxiliary component(s) such as a small capacitor(s).

[046] **Fig. 3A** is diagram depicting a panel level embodiment of disclosed subject matter. These designs facilitate a larger bias voltage in spite of a simpler bias circuit within each integrated circuit within each solar cell assembly. This larger bias voltage facilitates less recombination and better photo-voltaic efficiency; however this requires a solar panel with less conventional structure and assembly process.

[047] Solar panel **3000** includes plural solar cell assemblies **1000** which are connected in electrical series along panel-level power wires **3100** that provide a moderately large panel-level DC voltage which feeds panel-level converter **3200**. Panel-level converter **3200** provides panel-level AC bias that feeds a panel-level bias wire **3300** that connects in electrical parallel to every solar cell assembly.

[048] **Fig. 3B** is a diagram highlighting an integrated circuit embodiment and solar assembly design of **Fig. 3A**. Each solar cell assembly has three external connections: two are the emitter and base power outputs, shown as wires **1411** and **1421** on the solar cell back surface **1300**, and the third is the panel-level bias wire **3300** that feeds AC through input capacitor **1515** into IC **1500**. Here the bias circuit, such as a rectifier **1516**, rectifies AC to pulsed DC and optionally adjusts its voltage. This pulsed DC feeds bias wire **1430** that feeds the transparent conductive layer **1250** on front surface **1200** of solar cell **1100**. The pulsed DC is current-integrated and voltage-smoothed by the capacitive load formed by transparent conductive layer **1250**, dielectric inner window **1240**, and semiconductor solar cell **1100**.

[049] Because the solar cell assemblies are connected in series, they have unequal DC offsets. Panel bias wire **3300** feeds each solar cell assembly **1000** via a coupling capacitor **1515** that provides DC isolation - thus one AC bias voltage can provide DC bias voltages on top of unequal DC offset voltages.

[050] The panel level embodiment has several advantages including: the panel-level converter serves many solar cells so it has a relatively small normalized cost (cost/watt of peak generated power); the panel-level DC provides moderately large voltage and thus facilitates conversion to AC with moderately large voltage, and thus facilitates moderately large voltage DC bias, and thus facilitates maximum PV efficiency;

the panel level embodiment allows for an especially simple bias circuit for each solar cell assembly, for example a simple coupling capacitor.

[051] However, the pane level embodiment requires a less conventional panel and assembly process, particularly panel bias wire **3300** and three connections (solar cell emitter wire **1410**, solar cell base wire **1420**, and panel bias wire **3300**) to each solar cell assembly.

[052] Solar cell fabrication and passivation determine the types and densities of recombination centers and traps near the front surface which determine what bias is optimum. Other factors, such as surface effects, various process details, and the average charge density in traps (which may depend on operating parameters, such as solar flux, cell temperature, and load resistance) may also play a part in determining bias. Thus, it may be difficult to correctly predict the average charge density, optimum bias, and cell efficiency improvement.

[053] One theory suggests that the optimum bias should weakly repel minority carriers. Thus the optimum bias is close to an emitter voltage in an N-type semiconductor. Another theory suggests the optimum bias should counter-balance trapped charges near the front surface. Thus, an optimum bias may be approximately mid-way between the emitter and base. While yet another theory suggests the optimum bias should be midway between the voltage slightly inboard of the base and the voltage slightly inboard of the emitter.

[054] Yet another theory is that as front surface voltage becomes more repulsive to minority carriers, then the recombination will reduce. Thus sufficiently strong repulsion will cause insignificant recombination. This theory encourages bias voltage that is repulsive and large.

[055] Therefore, the optimum bias may be more cleanly initially determined by experiments. For example, use a solar cell with front surface coating plus an adjustable bias source (an adjustable voltage source, or charge source or current source) with a corresponding meter and a system to apply a specified solar flux. Thus measure the curve of cell output current and voltage. Set the test conditions of solar flux and cell temperature. For example, 1,000 w/m<sup>2</sup> and 25 C are the defined standard test

conditions, STC. Fix one output parameter, such as load resistance, output voltage, or output current. Then scan the bias voltage and observe the corresponding output power and cell efficiency. This directly measures the bias that provides maximum output power, and the corresponding cell efficiency. Then measure the optimum bias and cell efficiency for each test condition in the relevant range of solar flux and cell temperature.

**[056]** Next, summarize these measurements by an algorithm that calculates optimum bias as a function of test conditions. Transform this into an algorithm to calculate optimum bias as a function of cell operating parameters (such as cell voltage, cell current, cell temperature. Translate this algorithm into an analog circuit or as a digital circuit with analog output as either may be used to guide the bias circuit.

**[057]** Another method to measure the optimum bias follows. For each bias level, measure the curve of cell voltage and current and calculate the maximum output power. After this is done for each bias level, plot the maximum output power versus bias level. Thus, directly measure the bias level that achieves the maximum output power. By doing this under various test conditions, measure the optimum versus test conditions.

**[058]** DLTS (Deep Level Transient Spectroscopy) methods are often used to measure traps and charges in or near a semiconductor junction between two terminals. This may be applied between the front surface transparent conductive layer and either the emitter or base contact. DLTS is a transient method and if and only if there is significant resistance or capacitance, the resulting slow time constants would obscure transient effects. Therefore, use a solar cell with very small area, possibly a fragment of a normal solar cell. Direct measurement of optimum bias and DLTS measurements may be used together to guide construction of a theory to describe trapped charges and front side bias effects.

**[059]** A front surface optimum bias enables output power with higher efficiency compared to a similar solar cell without a front surface optimum bias. In the latter case, suppose that near the front surface there are recombination centers, traps, and unbalanced net trapped charge that attract minority carriers. Therefore some E-field lines extend from these unbalanced charges to an electrode on the back surface. Some photo-generated

minority carriers will drift along this field-line towards the front surface unbalanced charges and recombination centers where the carrier energy will be wasted.

**[060]** Suppose there are traps in a solar cell near the front surface whose average charge varies with solar flux and temperature. The bias circuit may be engineered to counter-balance the variable charge traps across a range of solar flux and temperature.

**[061]** Further, compare a cell with an optimized bias with a solar cell that has additional fixed charges, with the opposite polarity, but does NOT have an optimized bias. At a specific solar flux and temperature, these variable traps may be counter-balanced by the fixed charges. However, as the solar flux and temperature change, the variable trapped charges will change which will create a corresponding un-balance between the fixed charges and the variable charge traps. This provides a net charge that will degrade power collection from photo-excited holes and electrons. Thus, the optimized front surface bias provided herein is an improvement over using a fixed charge to counter-balance traps with temperature-dependent average charge.

**WHAT IS CLAIMED IS:**

1. A photovoltaic solar cell assembly for generating electrical energy from light, said solar cell assembly comprising a front surface for receiving light and a front surface electrical bias activated by electrical energy generated by said solar cell assembly, said front surface electrical bias improving conversion efficiency for said solar cell assembly.
2. The photovoltaic solar cell of Claim 1, further comprising:  
a front surface for receiving light;  
a conductive layer positioned near or directly on said front surface; and  
a bias wire activated by at least one electrode on said solar cell, said electrode providing some of said electrical energy to said bias circuit, said bias wire transferring said electrical energy to said transparent layer to activate a front surface electrical bias.
3. The photovoltaic solar cell of Claim 1, wherein said front surface bias and said electrode have approximately equivalent voltages.
4. The photovoltaic solar cell of Claim 1, wherein said front surface bias is directly connected to said electrode, said electrode having the same polarity as minority carriers in the solar cell.
5. The photovoltaic solar cell of Claim 1, wherein said bias circuit further comprises a control, said control optimizing front surface bias to reduce the concentration of minority carriers near the front surface of the solar cell.
6. The photovoltaic solar cell of Claim 1, wherein said bias circuit further comprises a control, said control responsive to operating conditions of said solar cell.
7. The photovoltaic solar cell of Claim 1, further comprising a bypass protection circuit connected to base and emitter electrodes on said solar cell.

8. The photovoltaic solar cell of Claim 1, further comprising a bias circuit connecting said at least one electrode on said solar cell to said bias wire.
9. The photovoltaic solar cell of Claim 1 further comprising a bypass protection circuit connected to base and emitter electrodes on said solar cell, wherein said bypass circuit is at least partially unified with said bias circuit.
10. A solar panel comprising a plurality of photovoltaic solar cell assemblies for generating electrical energy from light, said solar cell assemblies at least partially connected in series, at least one of said solar cell assembly comprising a front surface for receiving light and a front surface bias activated by electrical energy generated by at least two of said solar cell assemblies, said front surface bias improving conversion efficiency for said solar cell assembly.

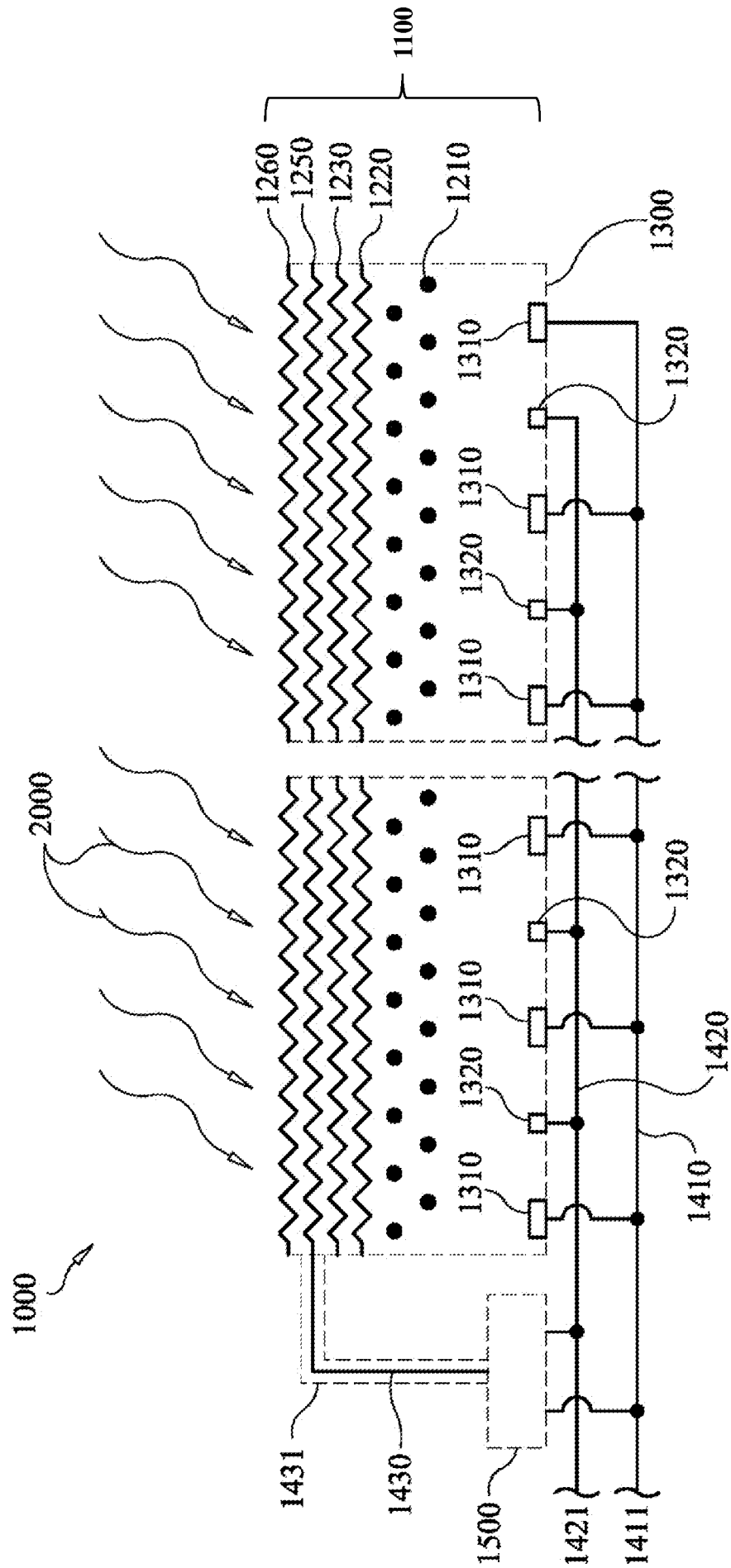


FIG. 1A

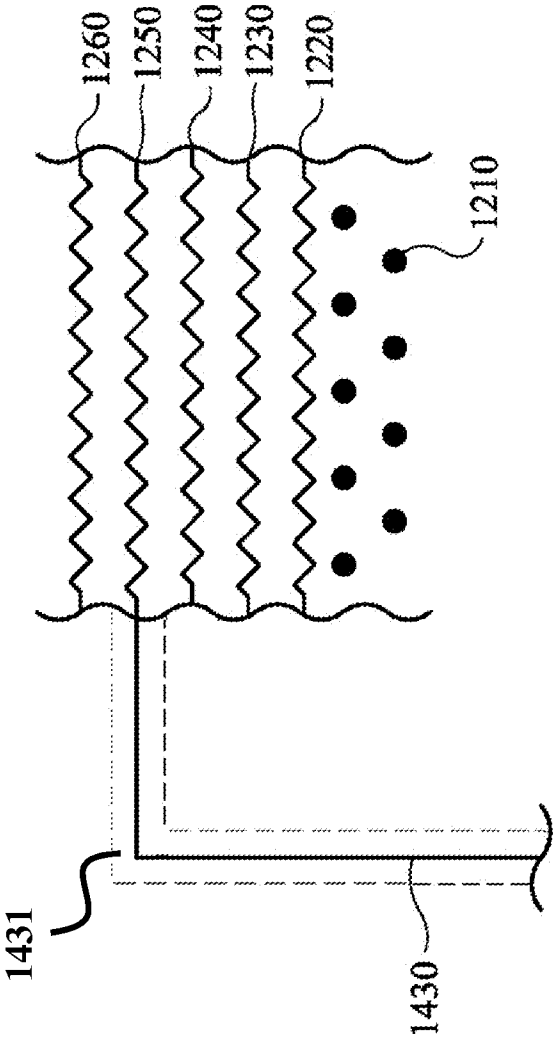


FIG. 1B

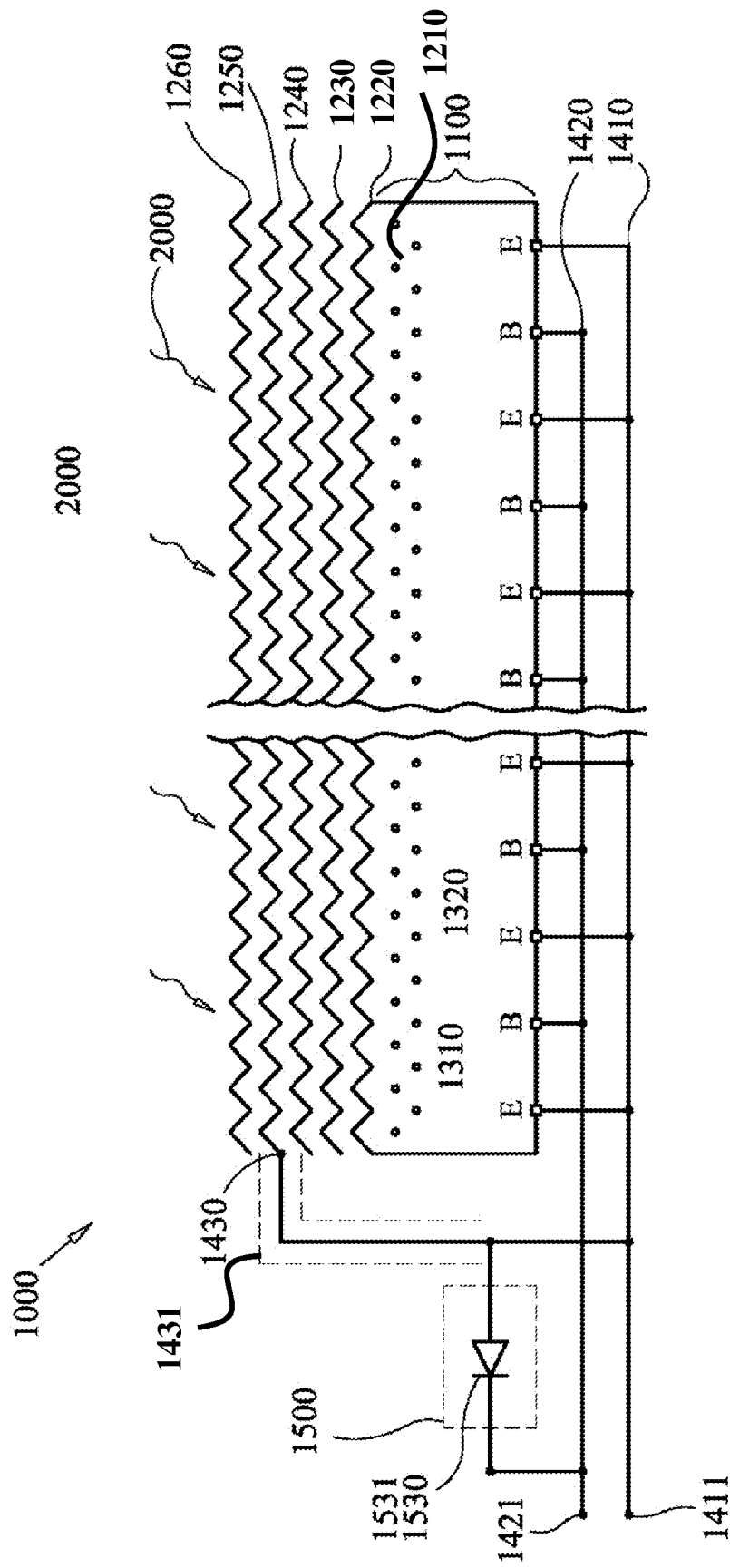
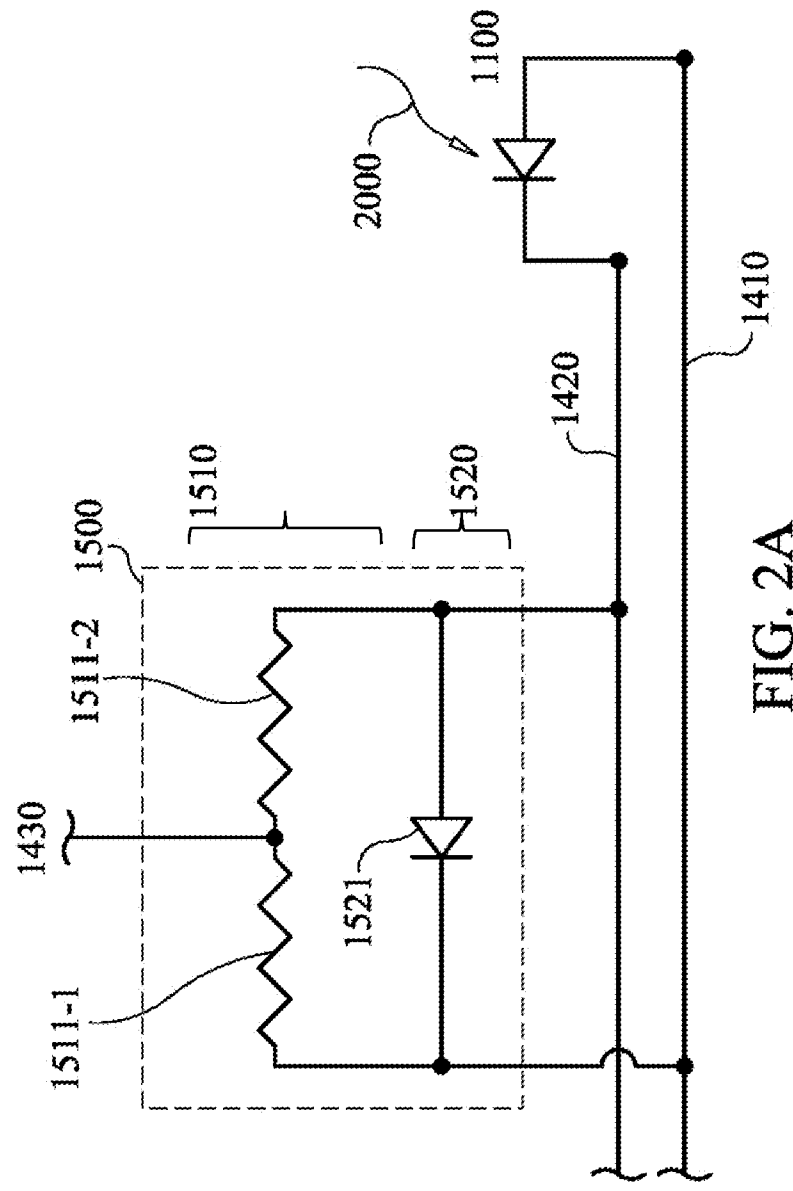


FIG. 1C



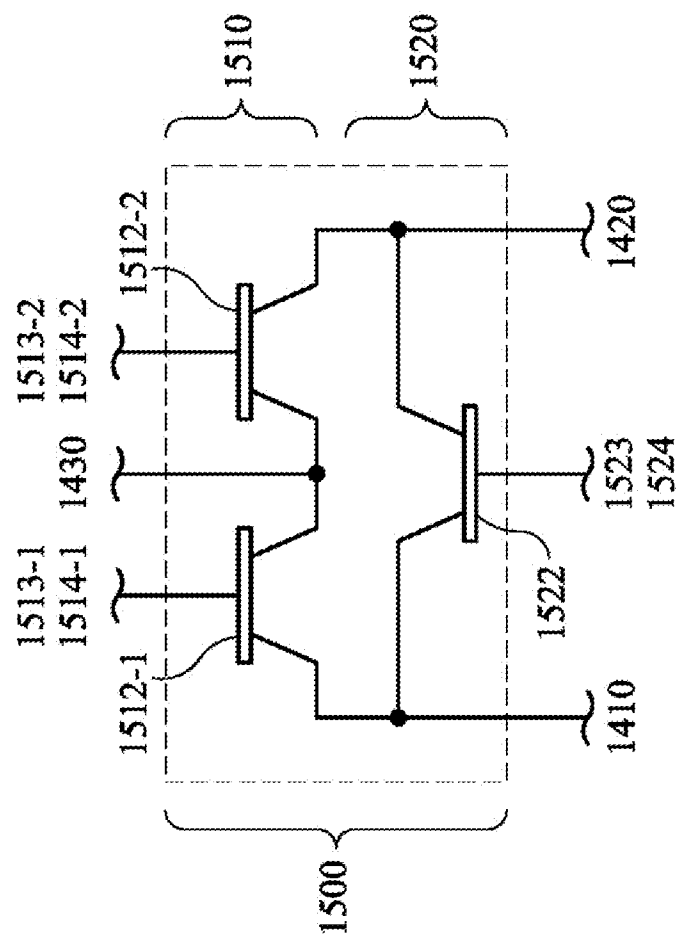


FIG. 2B

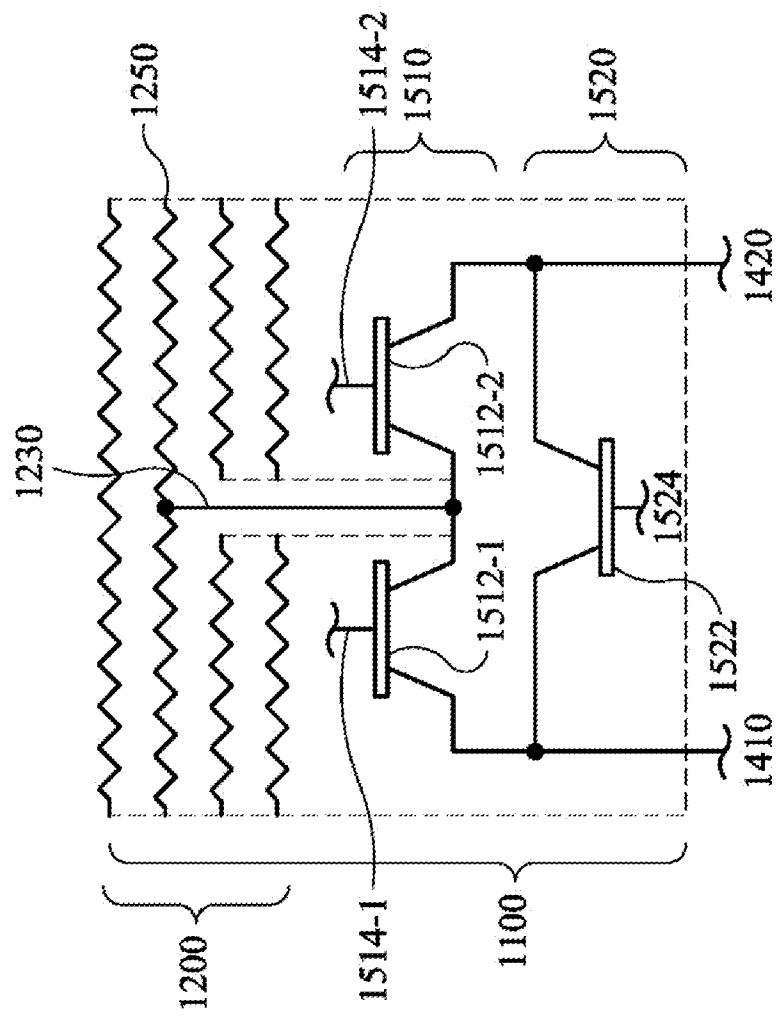


FIG. 2C

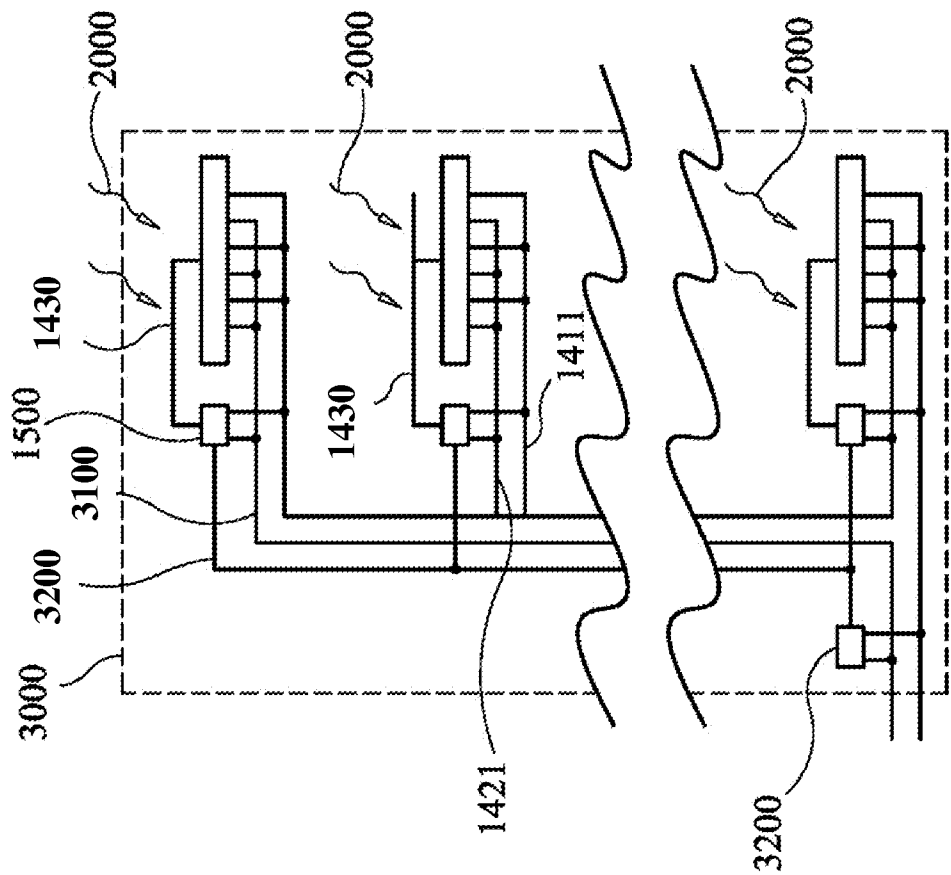


FIG. 3A

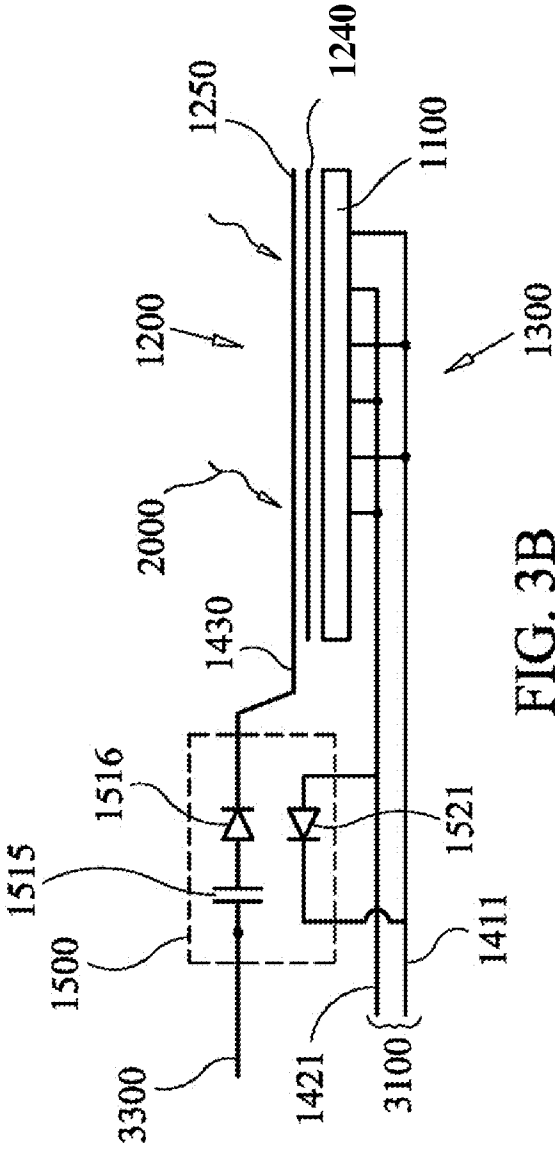


FIG. 3B